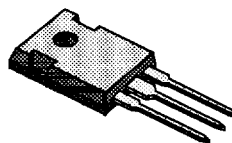


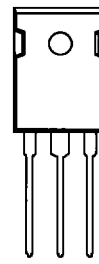
PRODUCT SUMMARY

$V_{(BR)DSS}$ (V)	$r_{DS(ON)}$ (Ω)	I_D (A)
100	0.040	45

TO-247 AD



TOP VIEW



1 GATE
2 DRAIN
3 SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	45	A
	$T_C = 100^\circ\text{C}$		27	
Pulsed Drain Current ¹		I_{DM}	180	
Avalanche Current (See Figure 9)		I_{AR}	45	
Avalanche Energy	$L = 0.3\text{ mH}$	E_A	300	mJ
Repetitive Avalanche Energy ²	$L = 0.02\text{ mH}$	E_{AR}	20	
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	150	W
	$T_C = 100^\circ\text{C}$		60	
Operating Junction & Storage Temperature Range		T_J, T_{stg}	-55 to 150	$^\circ\text{C}$
Lead Temperature ($1/16"$ from case for 10 sec.)		T_L	300	

4

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	R_{thJC}		0.83	K/W
Junction-to-Ambient	R_{thJA}		40	
Case-to-Sink	R_{thCS}	0.35		

¹Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, Figure 11).

²Duty cycle $\leq 1\%$, $T_C = 25^\circ\text{C}$.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	TYP	LIMITS		UNIT
				MIN	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$		100		V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$		2.0	4.0	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 80\text{ V}, V_{GS} = 0\text{ V}$			25	μA
		$V_{DS} = 0.8 \times V_{(BR)DSS}, V_{GS} = 0\text{ V}, T_J = 125^\circ\text{C}$			250	
On-State Drain Current ¹	$I_{D(ON)}$	$V_{DS} = 5\text{ V}, V_{GS} = 10\text{ V}$		45		A
Drain-Source On-State Resistance ¹	$r_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 27\text{ A}$	0.030		0.040	Ω
		$V_{GS} = 10\text{ V}, I_D = 27\text{ A}, T_J = 125^\circ\text{C}$	0.058		0.072	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 10\text{ V}, I_D = 27\text{ A}$		15		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0\text{ V}, V_{DS} = 25\text{ V}, f = 1\text{ MHz}$	3000			pF
Output Capacitance	C_{oss}		750			
Reverse Transfer Capacitance	C_{rss}		150			
Total Gate Charge ²	Q_g	$V_{DS} = 0.5 \times V_{(BR)DSS}, V_{GS} = 10\text{ V}, I_D = 45\text{ A}$	72		100	nC
Gate-Source Charge ²	Q_{gs}		26		35	
Gate-Drain Charge ²	Q_{gd}		31		40	
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DD} = 50\text{ V}, R_L = 1.1\text{ }\Omega$ $I_D \simeq 45\text{ A}, V_{GEN} = 10\text{ V}, R_G = 2.5\text{ }\Omega$	17		30	ns
Rise Time ²	t_r		80		120	
Turn-Off Delay Time ²	$t_{d(off)}$		40		60	
Fall Time ²	t_f		20		40	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				45	A
Pulsed Current ³	I_{SM}				180	
Forward Voltage ¹	V_{SD}	$I_F = I_S, V_{GS} = 0\text{ V}$			2.5	V
Reverse Recovery Time	t_{rr}	$I_F = I_S, dI_F/dt = 100\text{ A}/\mu\text{s}$	130			ns
Reverse Recovery Charge	Q_{rr}		0.31			μC

¹Pulse test: Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature (refer to transient thermal impedance data, Figure 11).

Figure 1. Output Characteristics

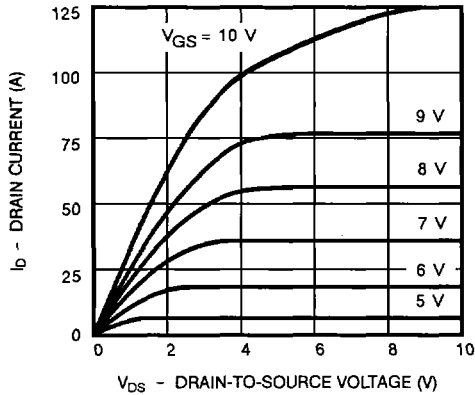


Figure 2. Transfer Characteristics

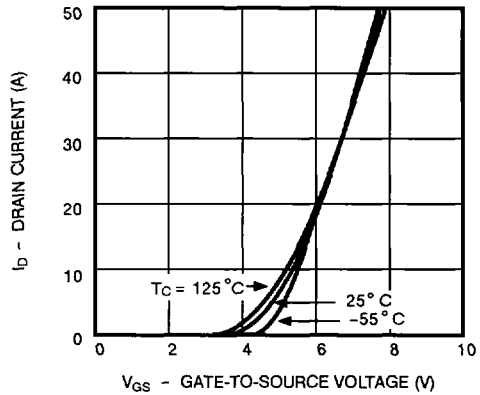


Figure 3. Transconductance

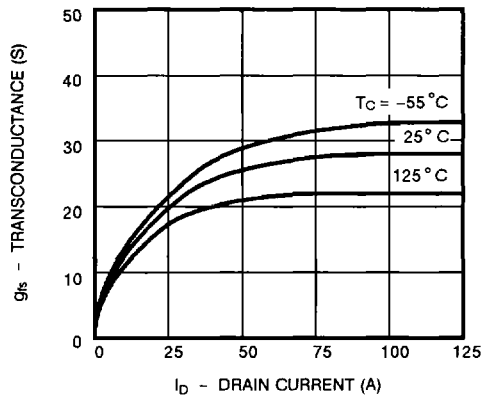


Figure 4. On-Resistance

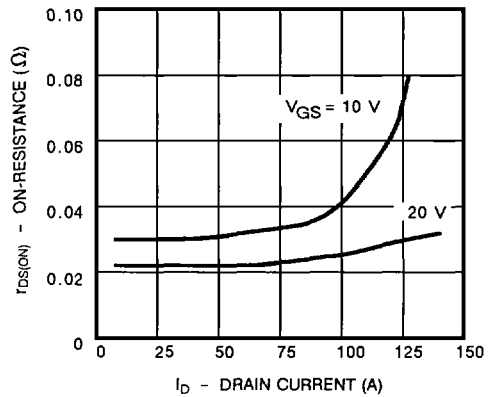


Figure 5. Capacitance

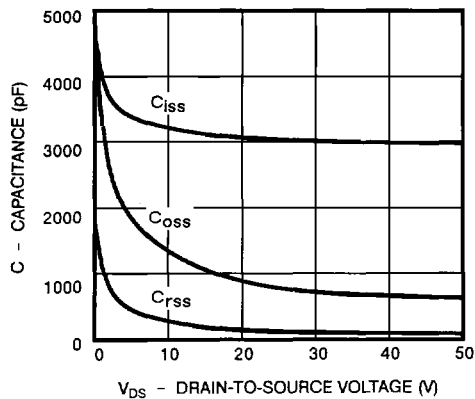
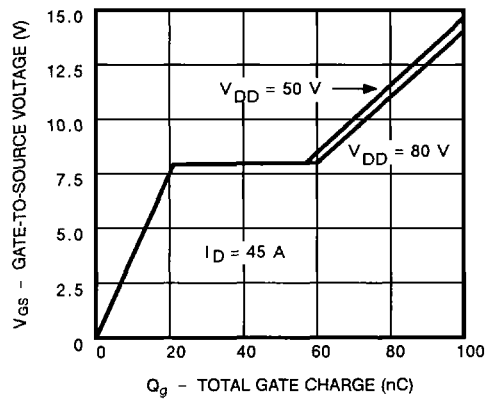


Figure 6. Gate Charge



TYPICAL CHARACTERISTICS (Cont'd)

Figure 7. On-Resistance vs. Junction Temperature

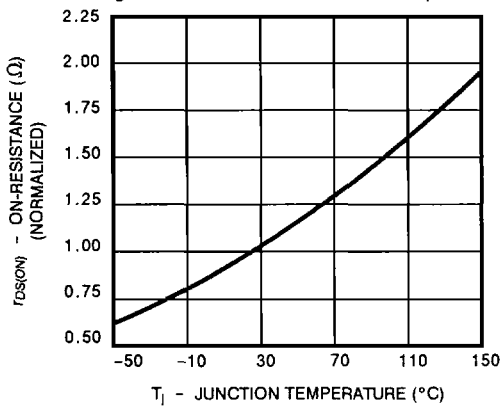
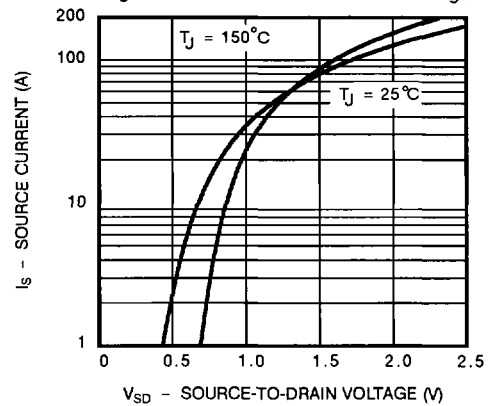


Figure 8. Source-Drain Diode Forward Voltage



THERMAL RATINGS

Figure 9. Maximum Avalanche and Drain Current vs. Case Temperature

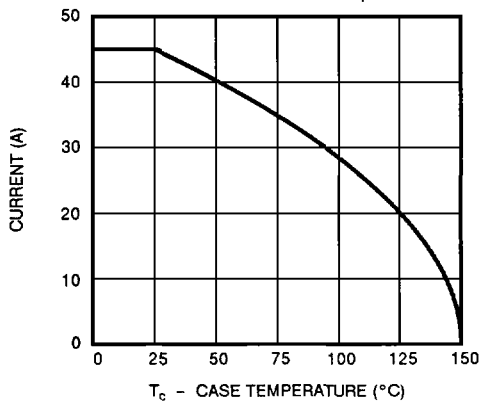


Figure 10. Safe Operating Area

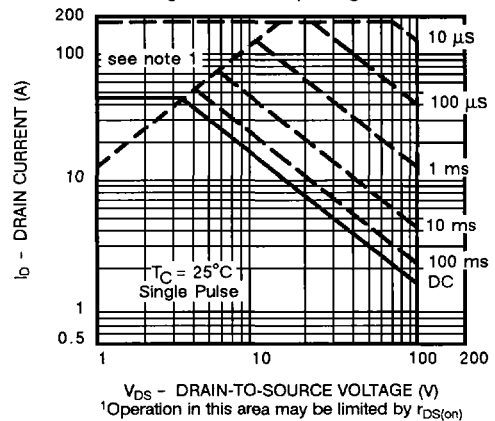


Figure 11. Normalized Effective Transient Thermal Impedance, Junction-to-Case

